Search Notes

Application/Control No.	Applicant(s)/Patent Reexamination	under
10/735,560	WON, NARA	
Examiner	Art Unit	
JOHN J. LEE	2618	

	SEARCHED				
Class	Subclass	Date	Examiner		
455	333,334 316,550.1 127.3,91 108	8/28/2008	J.L		
455	102,226.1	8/28/2008	J.L		
455	73,252.1	8/28/2008	J.L		
455	136,138	8/28/2008	J.L		
455	112	8/28/2008	J.L		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	8/28/2008	J.L		